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May 2014

FGB3440G2_F085 / FGD3440G2_F085 FGP3440G2_F085

EcoSPARK®2 335mJ, 400V, N-Channel Ignition IGBT

Features

- SCIS Energy = 335mJ at T_{.1} = 25°C
- Logic Level Gate Drive
- Qualified to AEC Q101
- RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- Coil On Plug Applications



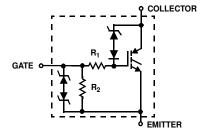
Package



Symbol







Device Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units	
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1mA)	400	V	
BV _{ECS}	mitter to Collector Voltage - Reverse Battery Condition (I _C = 10mA) 28			
E _{SCIS25}	Self Clamping Inductive Switching Energy (Note 1) 335			
E _{SCIS150}	Self Clamping Inductive Switching Energy (Note 2)	195	mJ	
I _{C25}	Collector Current Continuous, at V _{GE} = 4.0V, T _C = 25°C	26.9	Α	
I _{C110}	Collector Current Continuous, at V _{GE} = 4.0V, T _C = 110°C		Α	
V_{GEM}	Gate to Emitter Voltage Continuous		V	
В	Power Dissipation Total, at T _C = 25°C		W	
r _D	Power Dissipation Derating, for T _C > 25°C		W/°C	
T_J	Operating Junction Temperature Range	-40 to +175	°C	
T _{STG}	Storage Junction Temperature Range -40 to		°C	
TL	Max. Lead Temp. for Soldering (Leads at 1.6mm from case for 10s) 300		°C	
T _{PKG}	Max. Lead Temp. for Soldering (Package Body for 10s) 260		°C	
ESD	Electrostatic Discharge Voltage at 100 pF, 1500 Ω	4	kV	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FGB3440G2	FGB3440G2_F085	TO-263AB	330mm	24mm	800
FGD3440G2	FGD3440G2_F085	TO-252AA	330mm	16mm	2500
FGP3440G2	FGP3440G2_F085	TO-220AB	Tube	N/A	50

Electrical Characteristics T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units

Off State Characteristics

BV _{CER}		I _{CE} = 2mA, V_{GE} = 0, or to Emitter Breakdown Voltage R_{GE} = 1K Ω , $T_{,l}$ = -40 to 150°C		370	400	430	٧
BV _{CES}	Collector to Emitter Breakdown Voltage	$I_{CE} = 10\text{mA}, V_{GE} = 0\text{V},$ $R_{GE} = 0,$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		390	420	450	٧
BV _{ECS}	Emitter to Collector Breakdown Voltage	I_{CE} = -20mA, V_{GE} = 0V, T_J = 25°C		28	-	1	V
BV _{GES}	Gate to Emitter Breakdown Voltage	I _{GES} = ±2mA		±12	±14	-	V
1	Collector to Emitter Leakage Current	$V_{CE} = 250V, R_{GE} = 1K\Omega$	$T_{J} = 25^{\circ}C$	-	-	25	μΑ
ICER	Collector to Emitter Leakage Current		$T_{J} = 150^{\circ}C$	-	-	1	mA
	Emitter to Collector Leakage Current	V _{EC} = 24V,	$T_{J} = 25^{\circ}C$	-	-	1	mA
I _{ECS}	Limiter to Collector Leakage Current		$T_{J} = 150^{\circ}C$	-	-	40	IIIA
R ₁	Series Gate Resistance			-	120	-	Ω
R ₂	Gate to Emitter Resistance			10K	-	30K	Ω

On State Characteristics

V _{CE(S.}	Collector to Emitter Saturation Voltage	$I_{CE} = 6A, V_{GE} = 4V,$	$T_J = 25^{\circ}C$	-	1.1	1.2	V
V _{CE(S.}	Collector to Emitter Saturation Voltage	$I_{CE} = 10A, V_{GE} = 4.5V,$	$T_{J} = 150^{\circ}C$		1.3	1.45	V
V _{CE(S.}	(T) Collector to Emitter Saturation Voltage	$I_{CE} = 15A, V_{GE} = 4.5V,$	$T_{J} = 150^{\circ}C$	-	1.6	1.75	V
E _{SCIS}	Self Clamped Inductive Switching	L = 3.0 mHy, VGE = 5V RG = 1K Ω , (Note 1)	TJ = 25°C	1	-	335	mJ

Notes:

- 1: Self Clamping Inductive Switching Energy(Escis25) of 335mJ is based on the test conditions that is starting T_J=25 $^{\circ}$ C; L=3mHy, I_{SCIS}=15A,V_{CC}=100V during inductor charging and V_{CC}=0V during the time in clamp
- 2: Self Clamping Inductive Switching Energy (Escis150) of 195mJ is based on the test conditions that is starting T_J =150 $^{\circ}$ C; L=3mHy, Iscis=11.4A,Vcc=100V during inductor charging and Vcc=0V during the time in clamp.

Electrical Characteristics $T_A = 25^{\circ}C$ unless otherwise noted

Parameter

Dynamic Characteristics							
Q _{G(ON)}	Gate Charge	I _{CE} = 10A, V _{CE} = 12V, V _{GE} = 5V		-	24	-	nC
V	Gate to Emitter Threshold Voltage	I _{CE} = 1mA, V _{CE} = V _{GE} ,	$T_{J} = 25^{\circ}C$	1.3	1.7	2.2	V
$V_{GE(TH)}$	Cate to Emitter Threshold Voltage	ICE - IIIA, VCE - VGE,	$T_{\rm J} = 150^{\rm o}{\rm C}$	0.75	1.2	1.8	·
V_{GEP}	Gate to Emitter Plateau Voltage	V _{CE} = 12V, I _{CE} = 10A		-	2.8	-	V

Test Conditions

Min

Max Units

Switching Characteristics

Symbol

t _{d(ON)R}	Current Turn-On Delay Time-Resistive	02 . 2	-	1.0	4	μS
t_{rR}	Current Rise Time-Resistive	$V_{GE} = 5V, R_G = 1K\Omega$ $T_J = 25^{\circ}C,$	1	2.0	7	μS
t _{d(OFF)L}	Current Turn-Off Delay Time-Inductive		-	5.3	15	μS
t _{fL}	Current Fall Time-Inductive	$V_{GE} = 5V, R_{G} = 1K\Omega$ $I_{CE} = 6.5A, T_{J} = 25^{\circ}C,$	-	2.3	15	μS

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction to Case	-	-	0.9	°C/W

Typical Performance Curves

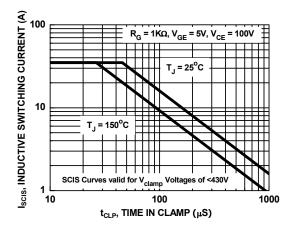


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

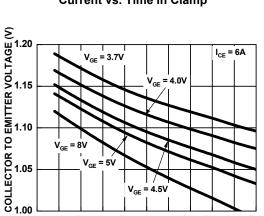


Figure 3. Collector to Emitter On-State Voltage vs. Junction Temperature

T_., JUNCTION TEMPERTURE (°C)

75 100 125 150 175

-75 -50

-25 0 25 50

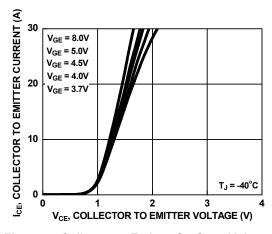


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

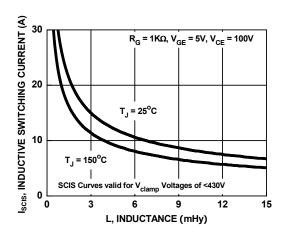


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

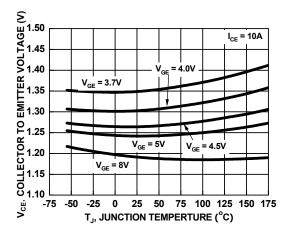


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

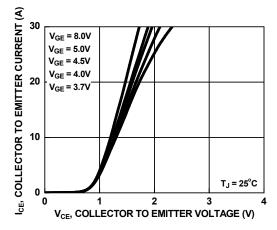


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

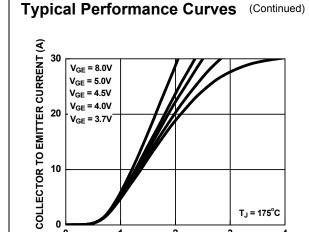


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

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2

V_{CE}, COLLECTOR TO EMITTER VOLTAGE (V)

3

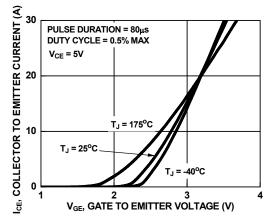


Figure 8. Transfer Characteristics

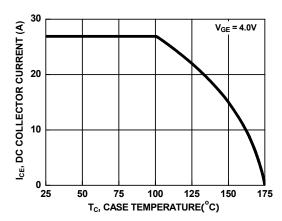


Figure 9. DC Collector Current vs. Case **Temperature**

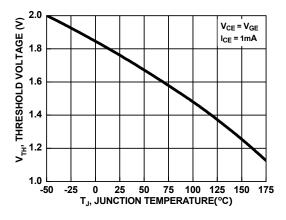


Figure 10. Threshold Voltage vs. Junction Temperature

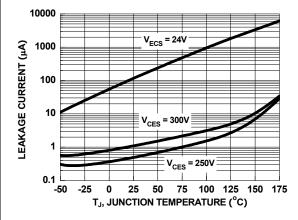


Figure 11. Leakage Current vs. Junction **Temperature**

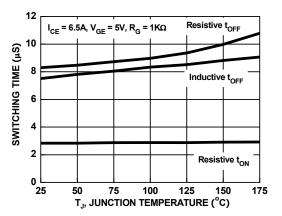
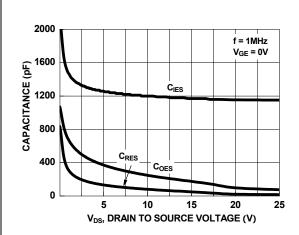


Figure 12. Switching Time vs. Junction **Temperature**



Typical Performance Curves (Continued)

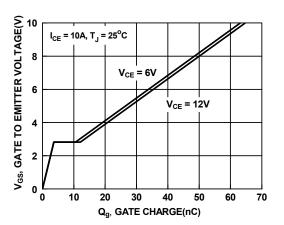


Figure 13. Capacitance vs. Collector to Emitter Voltage

Figure 14. Gate Charge

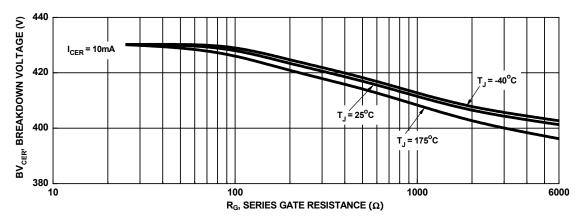


Figure 15. Break down Voltage vs. Series Gate Resistance

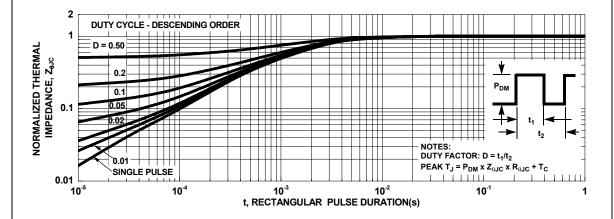
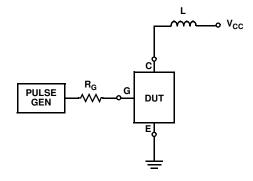


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

Test Circuit and Waveforms

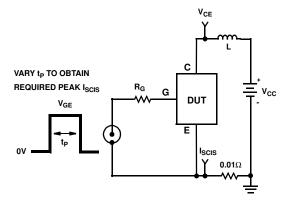


 $R_{G} = 1K\Omega$ B

DUT V_{CC} V_{CC}

Figure 17. Inductive Switching Test Circuit

Figure 18. t_{ON} and t_{OFF} Switching Test Circuit



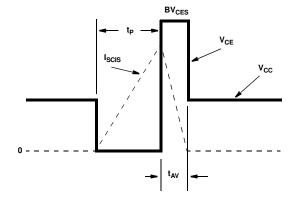


Figure 19. Energy Test Circuit

Figure 20. Energy Waveforms





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